

## IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

## **CB TEST CERTIFICATE**

**Product** 

Name and address of the applicant

Name and address of the manufacturer

Name and address of the factory

Note: When more than one factory, please report on page 2

Ratings and principal characteristics

Trademark (if any)

Customer's Testing Facility (CTF) Stage used

Model / Type Ref.

IP Speakers

Atlas Sound, L.P. 1601 Jack McKay Blvd. Ennis, TX 75119

United States of America

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Additional information on page 2

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All models: 9 - 48 VDC (Poe) or 12 - 18 VDC (local), 9W



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I8S-XX, I8SM-XX, I8S+, I8SM+, IP-8SM with enclosures FEST-I8S, SEA-I8S, SESTI8S, IP-FEST-S, IP-SEA-S, IP-SEST-S and IP-SEST-SNK.
I8SC-XX, I8SCM-XX, I8SCH-XX, I8SC+, I8SCM+, I8SCH+, I8SCF+, I8SCMF+, IP-SCM, IP-SDM, IP-SDMF, IP-SDMFLED, IP-SM-72, IP-SDM-72, IP-SDMF72, IP-SCM with enclosures FEST-I8SC, SEA-I8SC, SEST-I8SC, IP-FEST-SD, IPSEA-SD and IP-SEST-SD.

IP-SDH with enclosures SEA-I8SC, SEST-I8SC, IP-SEA-SD and IP-SEST-SD IHVP-XX, IHVP+, IP-HVP with enclosures FEST-IH, SEST-IH, IP-FEST-HVP and IPSEST-HVP.

IPDCM+, IP-DM with enclosures IPDC-FEC, IP-FEC-DM, IPDC-SES and IP-SEC-DM IPDCMF+, IPDC-DSE+, IP-DD, IPDSC-DSE+, IP-DDS, IP-PM8GD, I128SYS, I128SYSM, IDT12-XX, IDT12M-XX, I128SYS+, I128SYSM+, IDT12+, IDT12M+, IP12SYSM, IP-12SYSMF, IP-22SYSMF, IPS-ZCM, IP-ZCM, IPS-ZCM-XX,

ZCM-V2+ with enclosures included;

IP-SDM-LS, IP-SDM-LS2 with enclosure 195-712

IP-SDM-LF with enclosure 195-312

Where XX may be any alphanumeric digits

This CB Test Certificate is issued by the National Certification Body

Intertek Testing Services NA, Inc.

Date: 2020-07-13

545 E. Algonquin Road, Suite F, Arlington Heights, IL 60005, United States of America



Signature: John Quigley



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Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found to be in conformity with

As shown in the Test Report Ref. No. which forms part of this Certificate

Additional information on page 2

IEC 62368-1:2014

National differences:

EU Group Differences, CA, US

103596010CHI-001

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